Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/732,987	FYE ET AL.
Examiner	Art Unit
Jason M. Han	2875

SEARCHED					
Class	Subclass	Date	Examiner		
362	30	4/6/2005	JMH		
362	84	4/6/2005	JMH		
362	85	4/6/2005	ЈМН		
341	22	4/6/2005	ЈМН		
200	5	4/6/2005	ЈМН		
200	310	4/6/2005	ЈМН		
200	313	4/6/2005	JMH		
200	314	4/6/2005	ЈМН		
200	317	4/6/2005	JMH		

INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
•							

SEARCH NO (INCLUDING SEARCI)
	DATE	EXMR
Search History	4/6/2005	ЈМН
P.E. Stephen Husar	4/6/2005	JMH